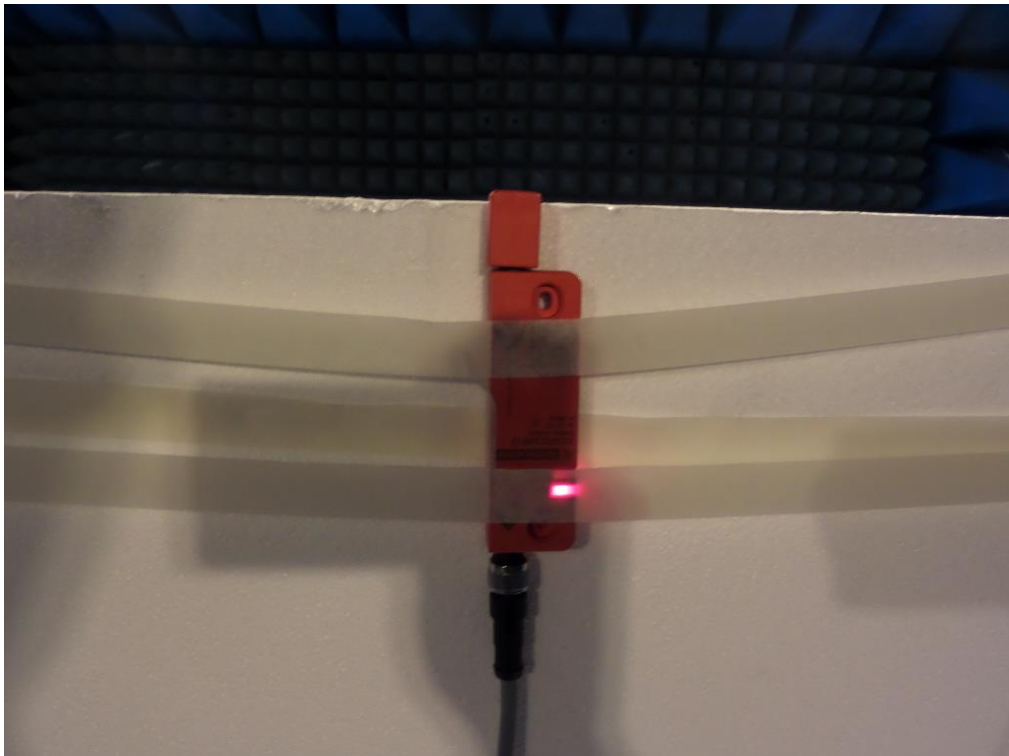
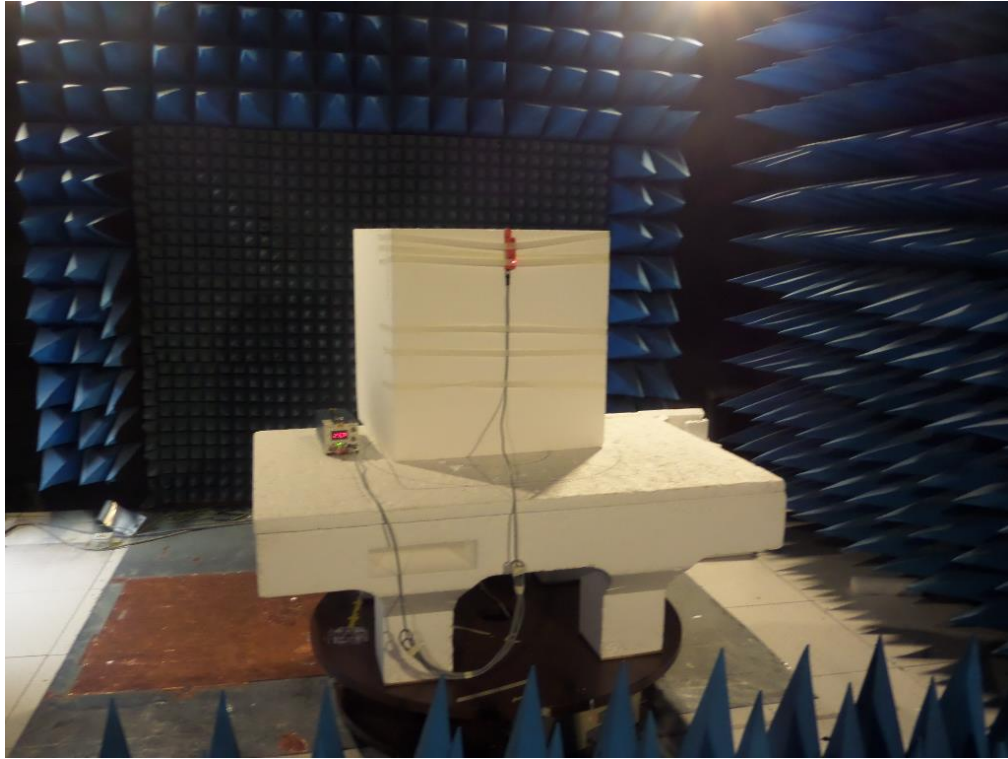
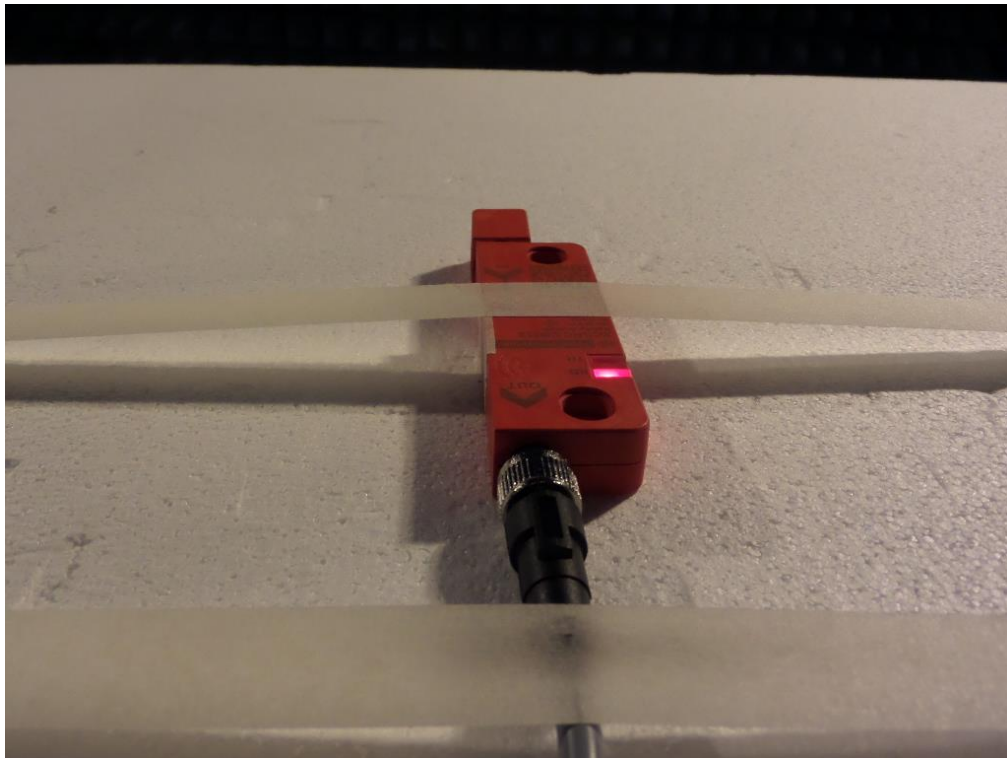
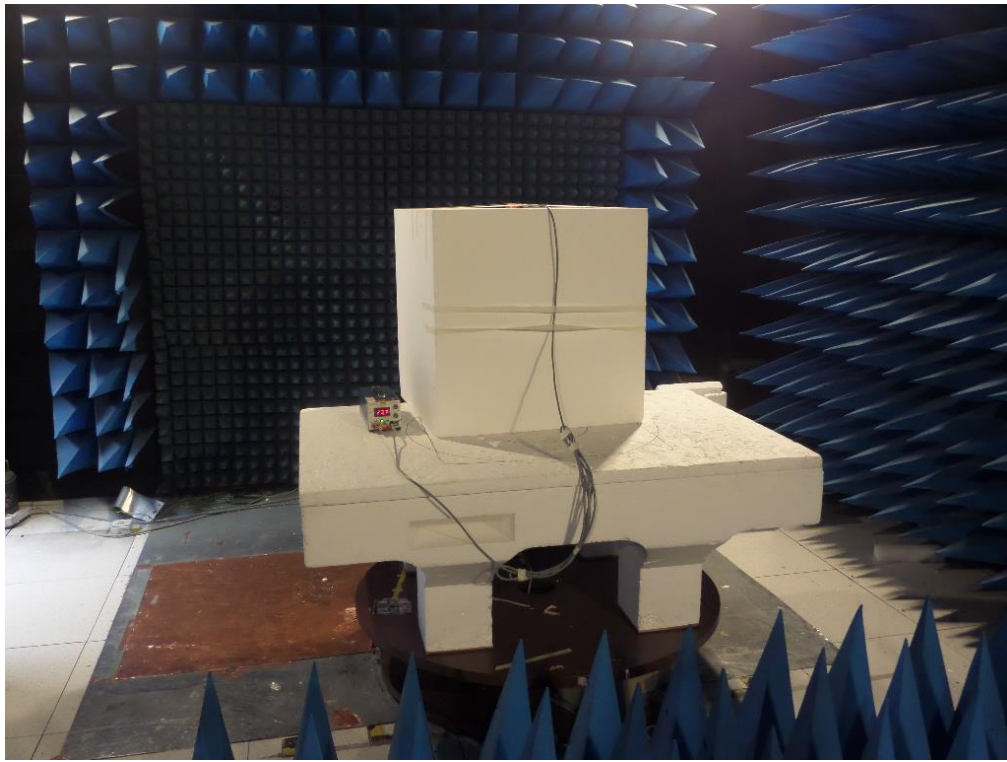


Anechoic chamber setup

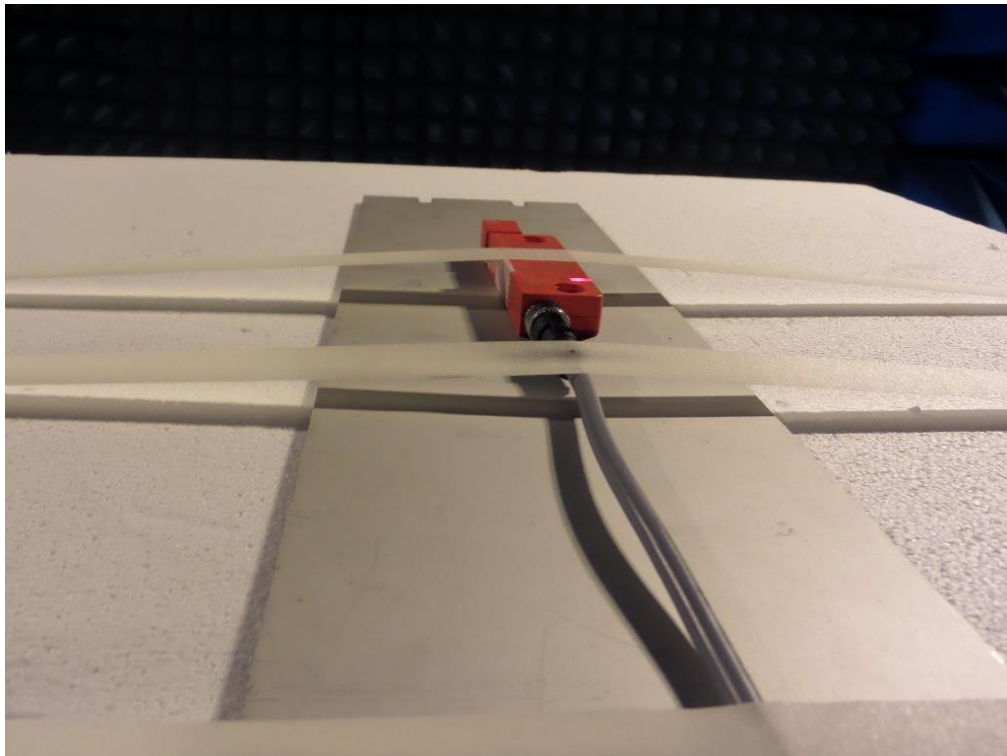
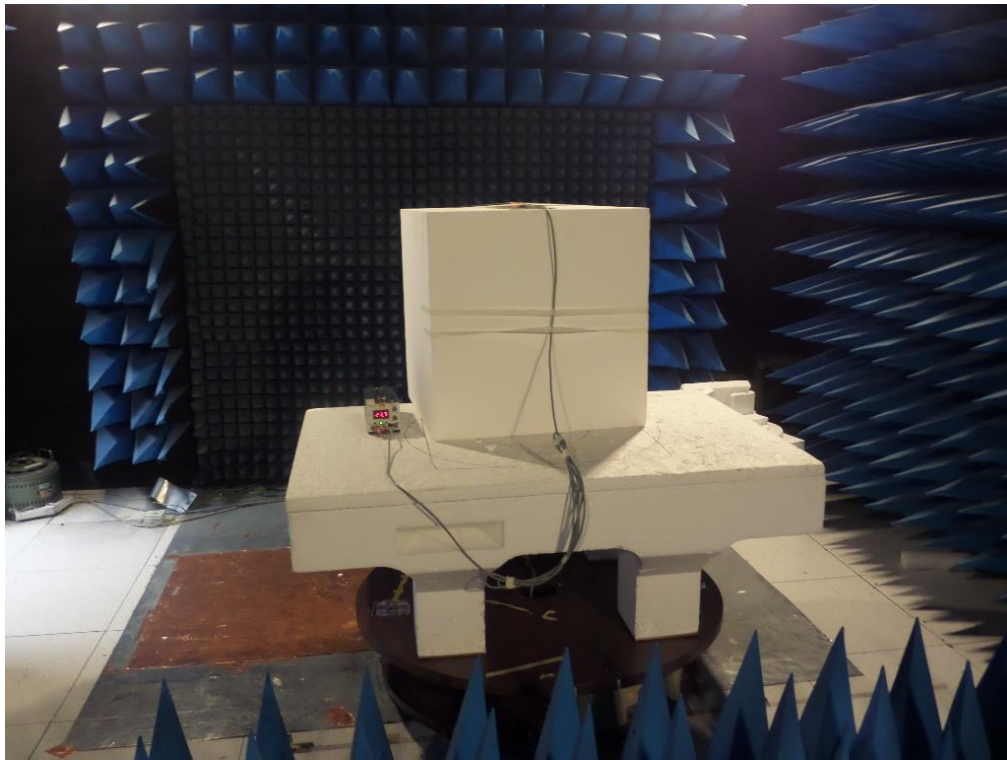
Position 1 – Non flush



Position 2 – Non flush

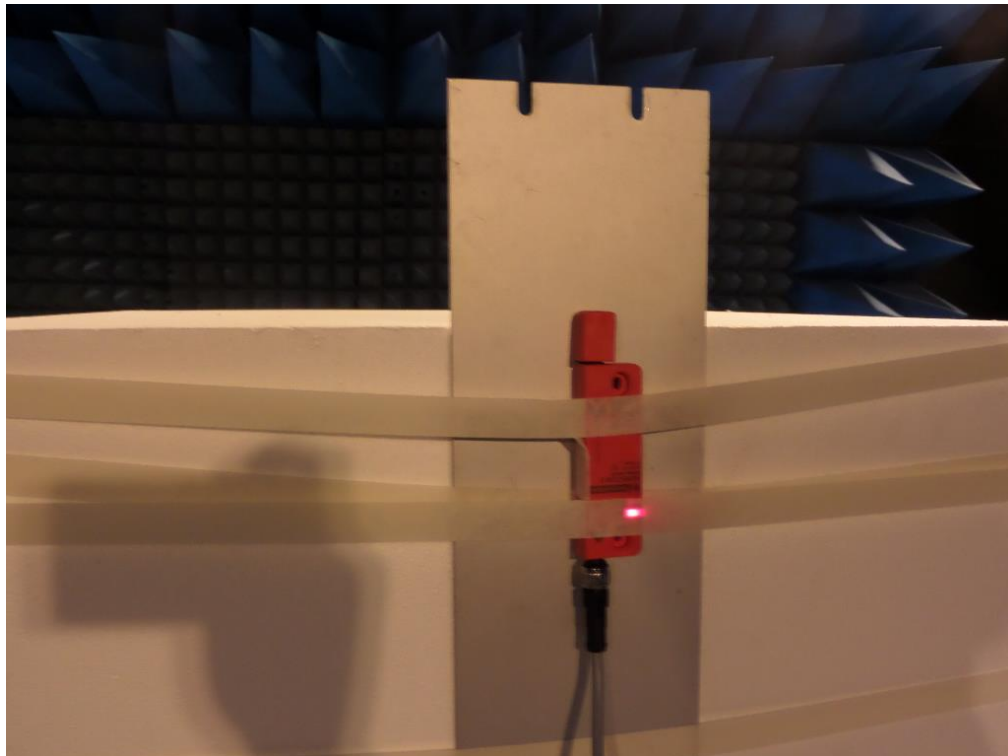
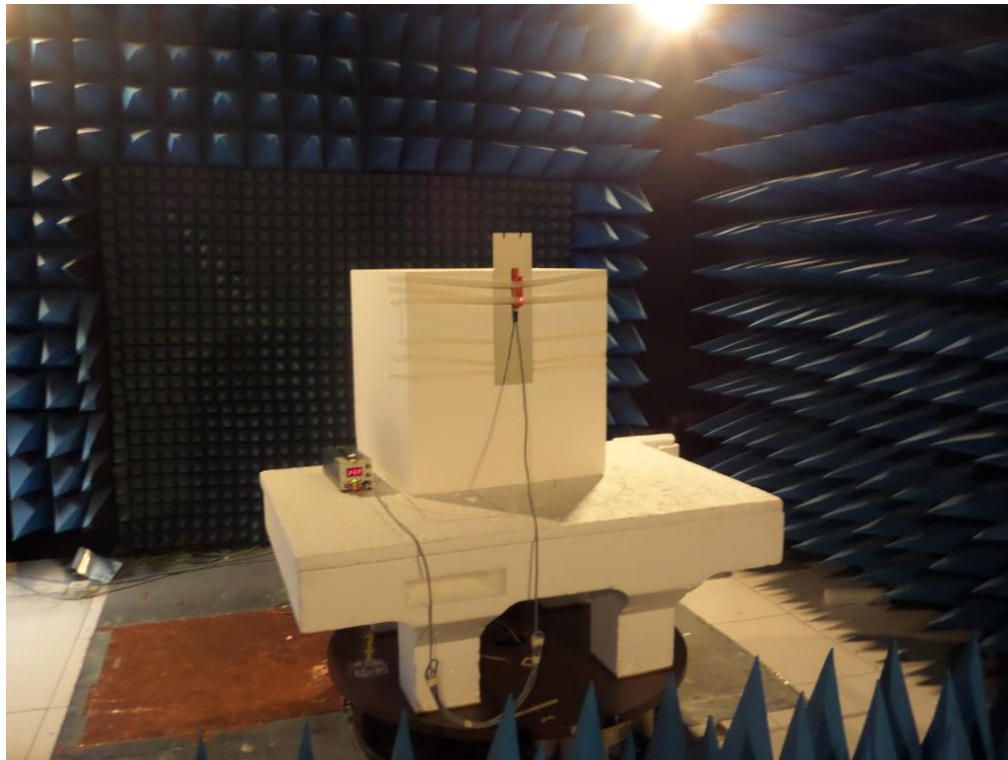


Position 1 – Metallic support





Position 2 – Metallic support



Anechoic chamber test site

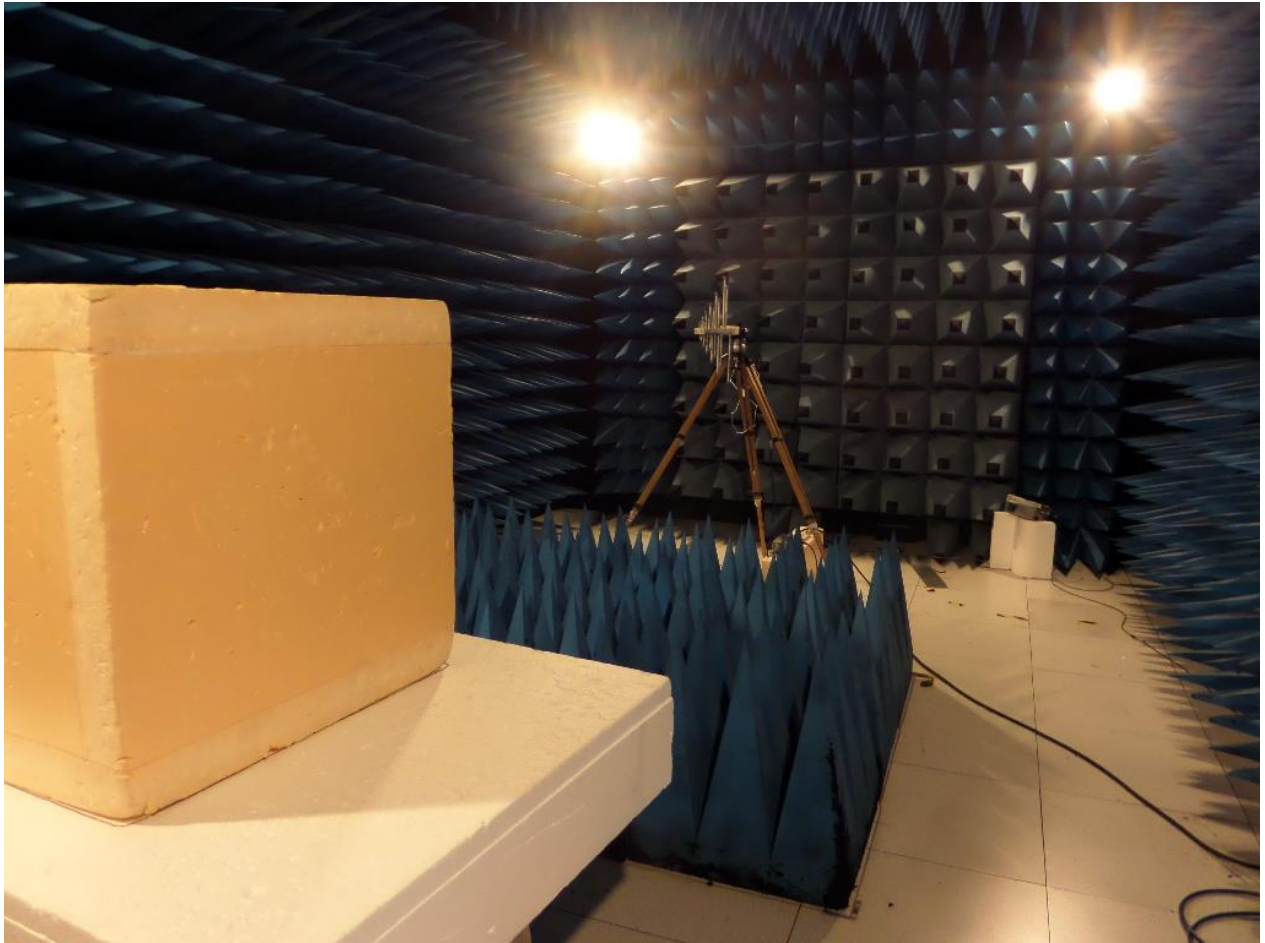
Pre-measure below 30 MHz



Pre-measure between 30 MHz to 200 MHz



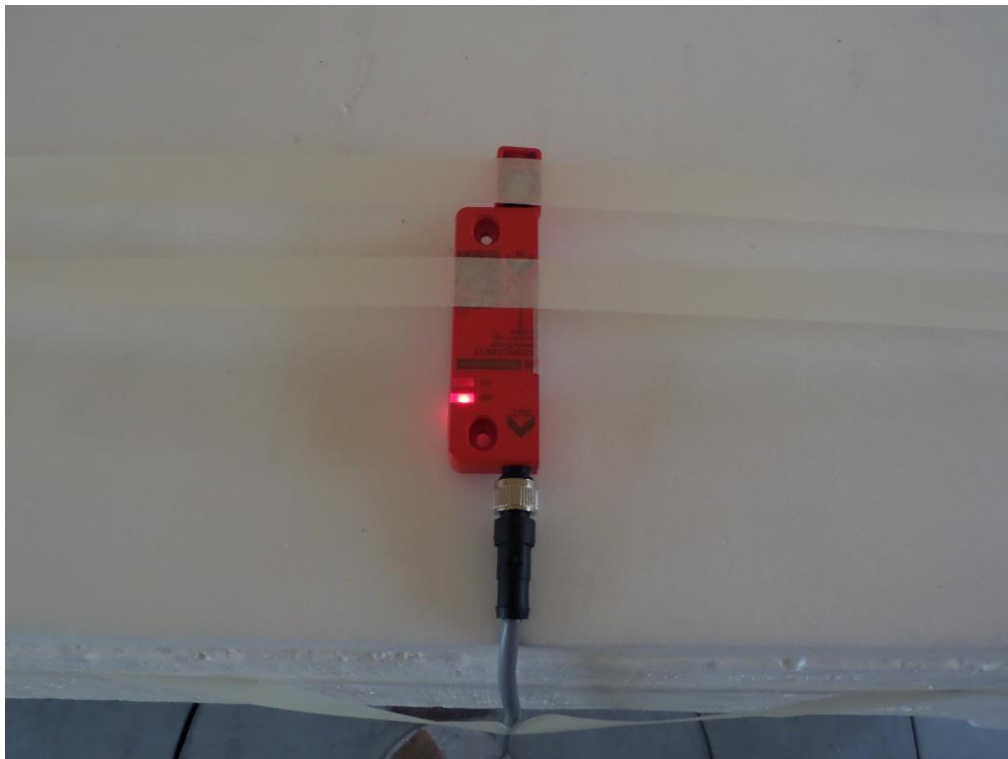
Pre-measure between 200 MHz to 1000 MHz





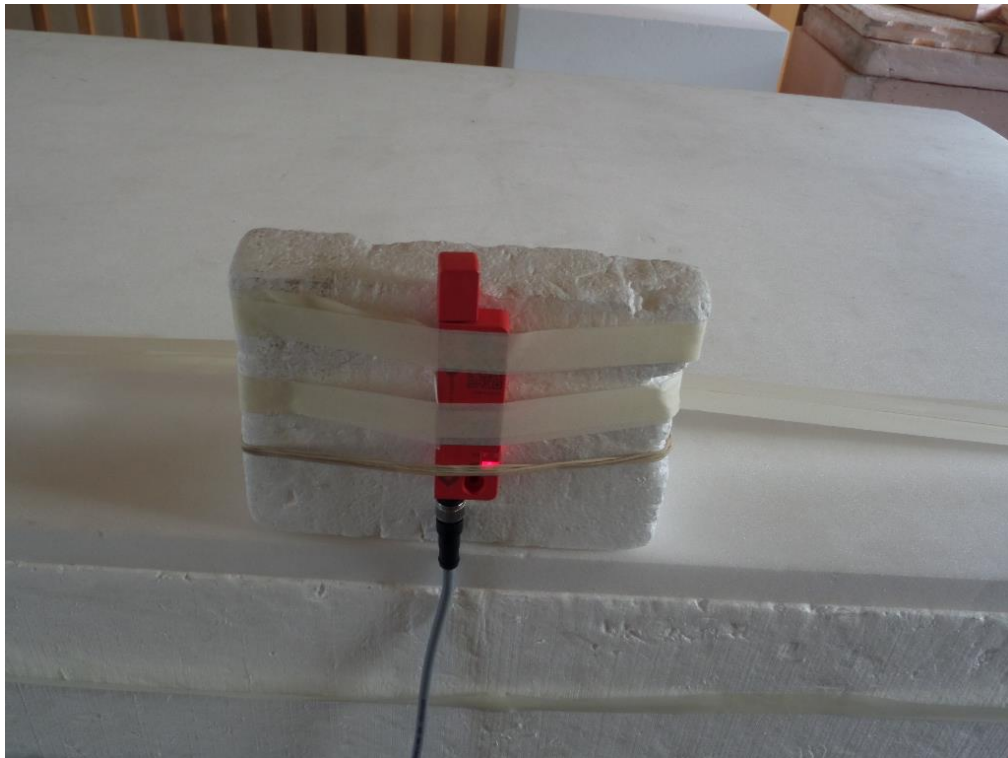
Open area setup

Position 1 – Non flush

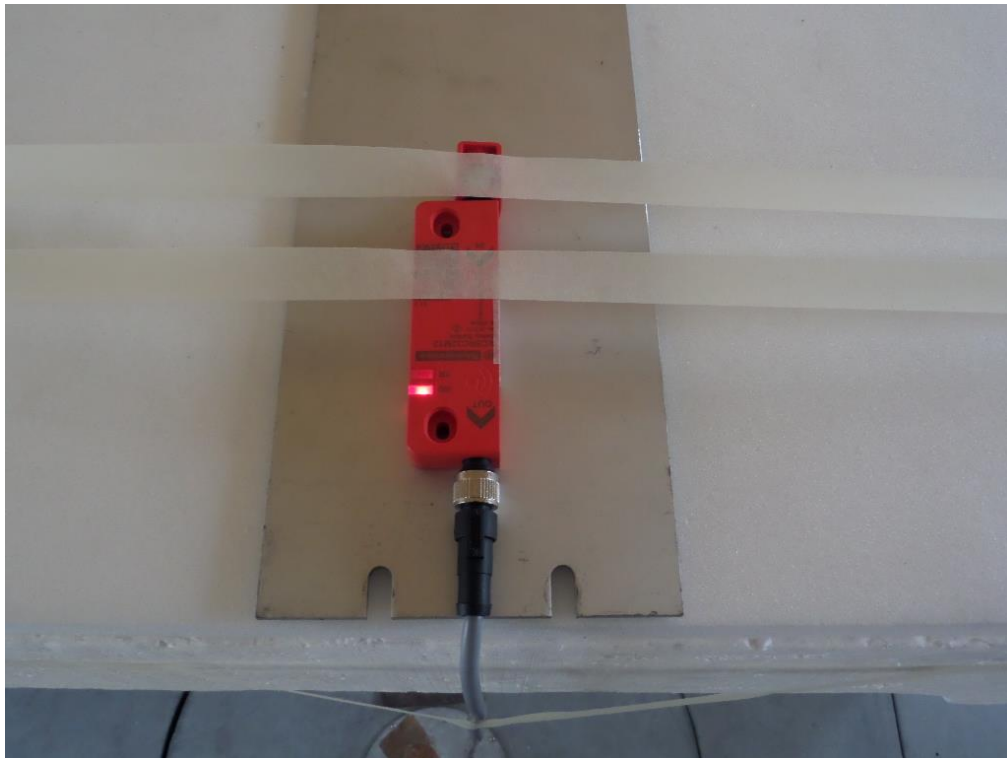




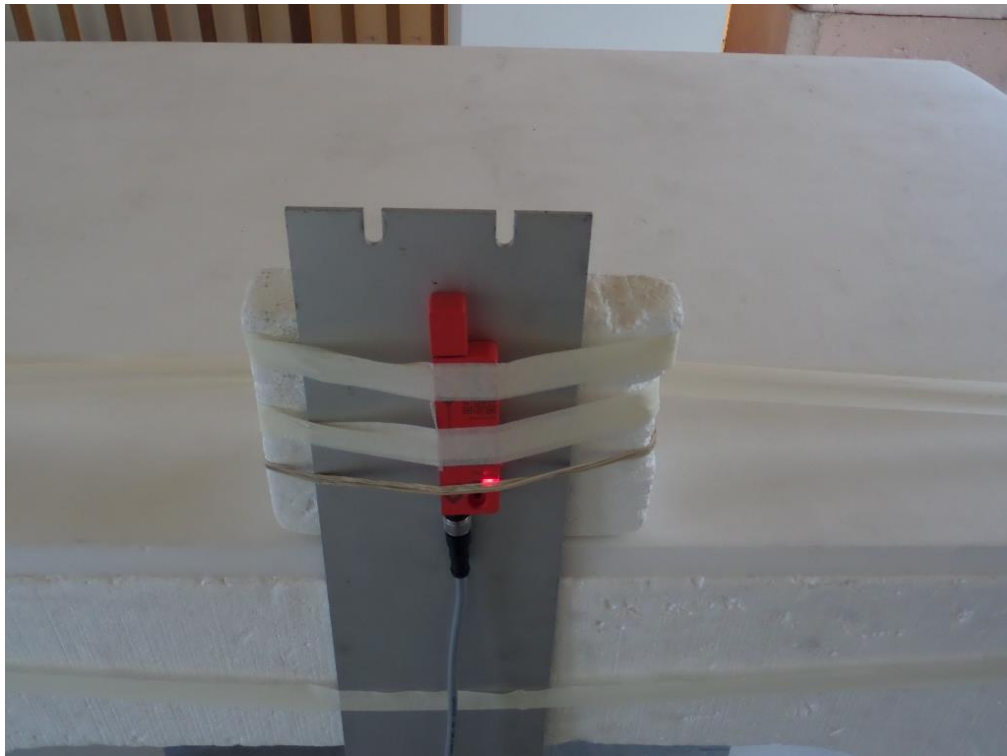
Position 2 – Non flush



Position 1 – Metallic support



Position 2 – Metallic support



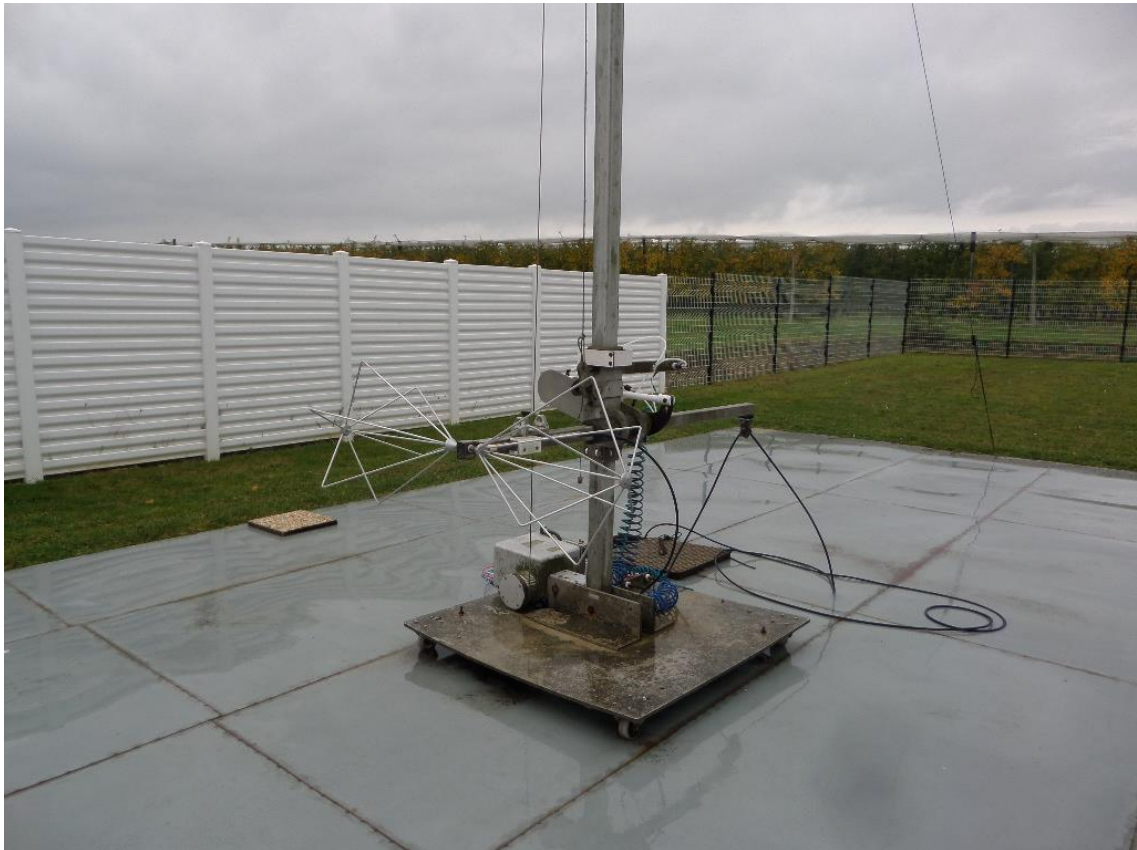
Open area test site

Measure below 30 MHz

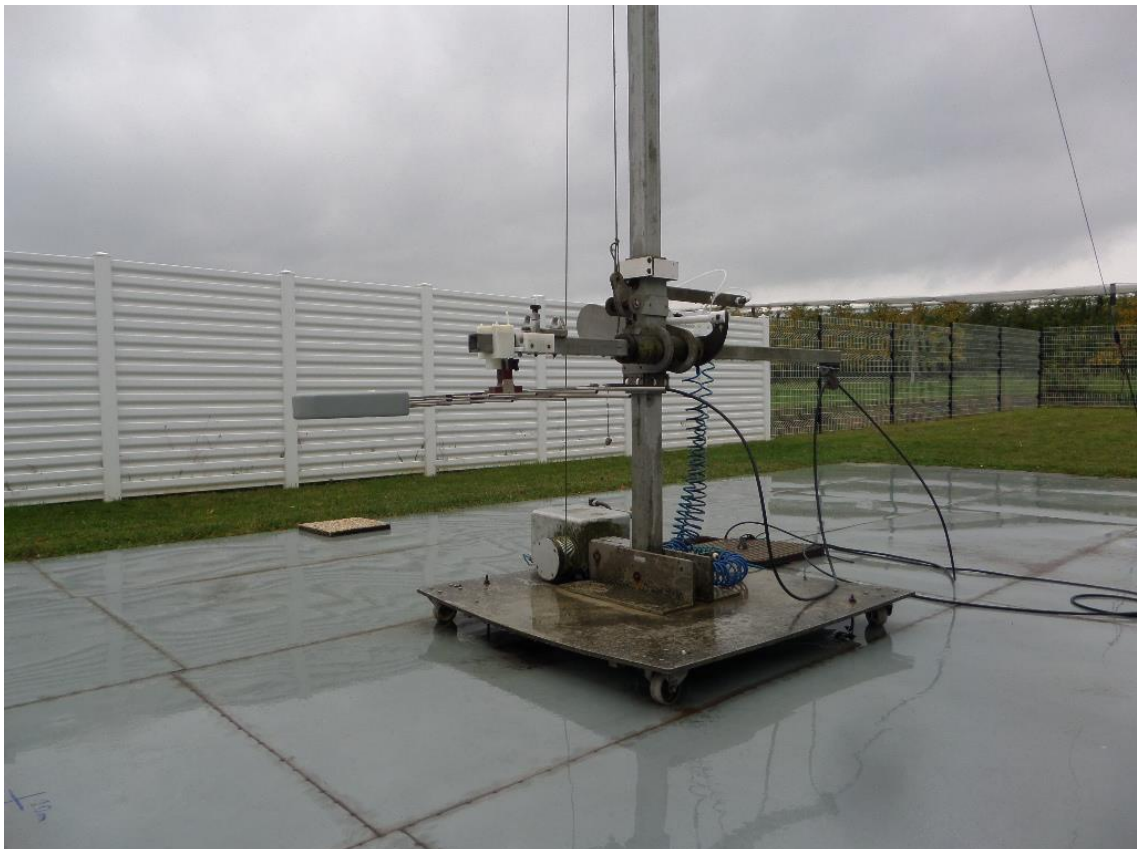




Measure between 30 MHz to 200 MHz



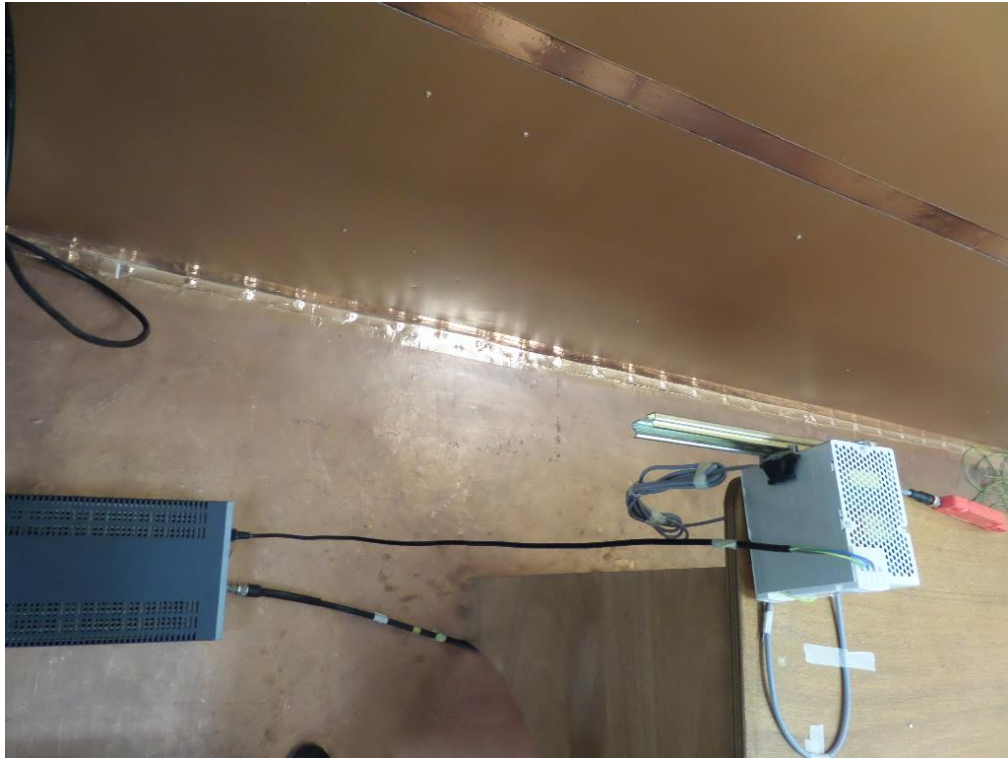
Measure between 200 MHz to 1000 MHz





Conducted measurement setup

**Non flush**





**With metallic support**





